# IP4359CX4

# **Dual channel low capacitance high performance ESD** protection

Rev. 1 — 6 August 2010

**Product data sheet** 

# 1. Product profile

## 1.1 General description

The IP4359CX4 is a dual channel low capacitance ElectroStatic Discharge (ESD) protection device, providing protection to downstream components from ESD voltages as high as  $\pm 15$  kV contact discharge and >  $\pm 15$  kV air discharge according the IEC 61000-4-2 model, far exceeding standard level 4.

The device is optimized for protection of high speed interfaces such as Universal Serial Bus (USB) 2.0, High Definition Multimedia Interface (HDMI), Digital Visual Interface (DVI) and other interfaces requiring very low capacitance ESD protection.

The device is available in two different heights. 0.61 mm and reduced maximum height of 0.5 mm. Both versions contain identical circuits and show an identical electrical performance. Both ESD protection channels share common ground connections, but are electrically separated, thereby preventing current back drive into the adjacent channel. IP4359CX4 is fabricated using monolithic silicon technology in a single Wafer-Level Chip-Scale Package (WLCSP). These features make the IP4359CX4 ideal for use in applications requiring component miniaturization such as mobile phone handsets and other portable electronic devices.

#### 1.2 Features and benefits

- Pb-free, RoHS compliant and free of halogen and antimony (Dark Green compliant)
- 2 ultra low input capacity rail-to-rail ESD protection diodes with C<sub>(I/O-GND)</sub> = 1.3 pF
- $\blacksquare$  R<sub>dvn</sub> = 0.45  $\Omega$
- Integrated ESD protection withstanding ±15 kV contact discharge and > ±15 kV air discharge, far exceeding IEC 61000-4-2 level 4
- Standard height version (0.61 mm) available as IP4359CX4/LF
- Reduced height version (maximum height of 0.5 mm) available as IP4359CX4/LF-H500
- 2 × 2 solder ball WLCSP with 0.4 mm pitch

#### 1.3 Applications

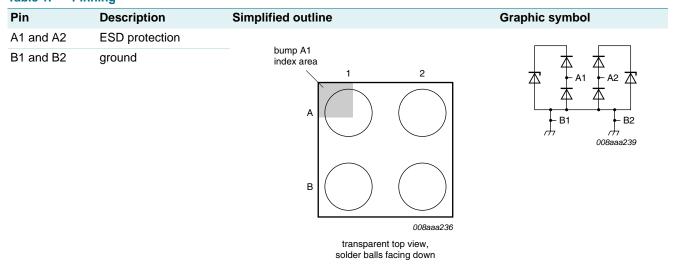
- High-speed interface ESD protection such as USB 2.0, HDMI, DVI etc.
- Interfaces with special requirements on low capacitive ESD protection
- Interfaces requiring separation of the positive clamping voltage/current path



## **Dual channel low capacitance ESD protection**

# 2. Pinning information

Table 1. Pinning



# 3. Ordering information

Table 2. Ordering information

Type number	Package height	Package		
		Name	Description	Version
IP4359CX4/LF	standard[1]	WLCSP4	wafer level chip-size package; 4 bumps (2 $\times$ 2)	IP4359CX4
IP4359CX4/LF-H500	reduced[2]	WLCSP4	wafer level chip-size package; 4 bumps $(2 \times 2)$	IP4359CX4

<sup>[1]</sup> For details see Table 5.

<sup>[2]</sup> For details see Table 6.

## **Dual channel low capacitance ESD protection**

# 4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	ľ	Vin	Max	Unit
$V_{I}$	input voltage	pins A1 and A2 to ground (B1, B2)	-	-0.5	+5.5	V
V <sub>ESD</sub> electrostatic discharge		pins A1 and A2 to ground (B1, B2)				
voltage	voltage	contact discharge	[1] _	-15	+15	kV
		air discharge	[1] _	-20	+20	kV
		IEC 61000-4-2 level 4; pins A1 and A2 to ground (B1, B2)				
		contact discharge	_	-8	+8	kV
		air discharge	_	-15	+15	kV
T <sub>stg</sub>	storage temperature		_	-55	+150	°C
T <sub>reflow(peak)</sub>	peak reflow temperature	10 s maximum	-		260	°C
T <sub>amb</sub>	ambient temperature		-	-35	+85	°C

<sup>[1]</sup> Device is qualified with 1000 pulses of  $\pm 15$  kV contact discharges each, according to the IEC61000-4-2 model and far exceeds the specified level 4 (8 kV contact discharge).

## 5. Characteristics

Table 4. Electrical characteristics

 $T_{amb}$  = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$C_{(I/O\text{-}GND)}$	input/output to ground capacitance	pins A1 and A2 to ground (B1, B2); $V_I = 3.3 \text{ V}$ ; $f = 1 \text{ MHz}$	[1] -	1.3	1.5	pF
$I_{LR}$	reverse leakage current	pins A1 and A2 to ground (B1, B2); $V_I = 3.3 \text{ V}$	-	-	100	nA
$V_{BRzd}$	Zener diode breakdown voltage	$I_{test} = 1 \text{ mA}$	6	-	9	V
V <sub>F</sub>	forward voltage		-	0.7	-	V
R <sub>dyn</sub>	dynamic resistance	I <sub>test</sub> = 1 A; IEC 61000-4-5				
		positive discharge	-	0.45	-	Ω
		negative discharge	-	0.45	-	Ω

<sup>[1]</sup> Guaranteed by design.

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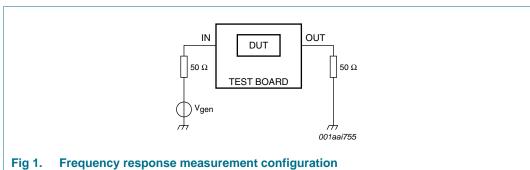
#### **Dual channel low capacitance ESD protection**

# **Application information**

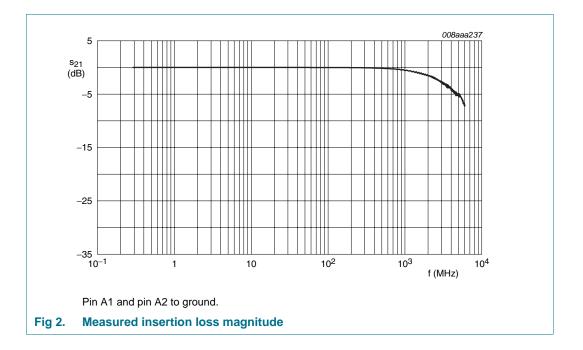
#### 6.1 Insertion loss

The IP4359CX4 is mainly designed as an ESD protection device for high speed interfaces such as USB 2.0, DVI and HDMI high speed data lines etc. The insertion loss measurement configuration of a typical 50  $\Omega$  NetWork Analyzer (NWA) system for evaluation of the IP4359CX4 is shown in Figure 1.

The insertion loss of IP4359CX4 is depicted in Figure 2.





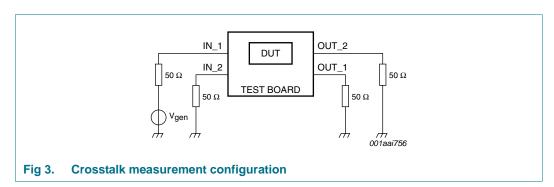


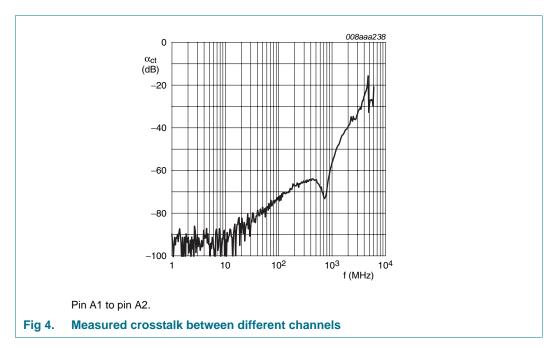
#### **Dual channel low capacitance ESD protection**

#### 6.2 Crosstalk

The crosstalk measurement configuration of a typical 50  $\Omega$  NWA system for evaluation of the IP4359CX4 is shown in Figure 3.

The crosstalk measurement results of IP4359CX4 are depicted in Figure 4.





## **Dual channel low capacitance ESD protection**

# 7. Package outline

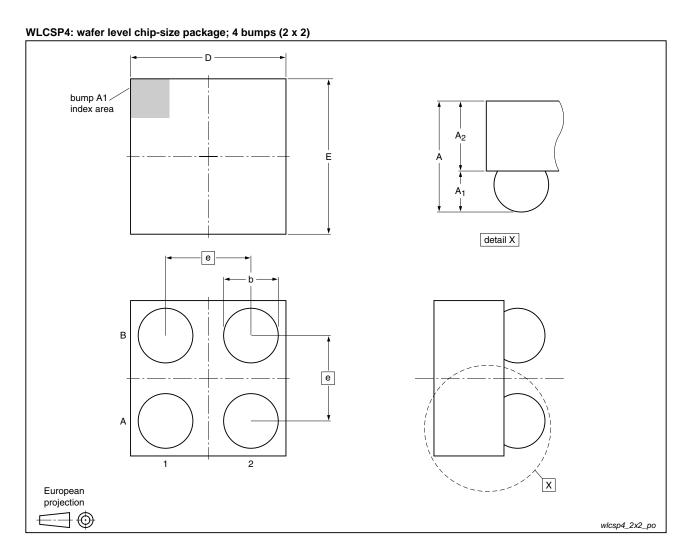


Fig 5. Package outline IP4359CX4 (WLCSP4)

Table 5. Dimensions of IP4359CX4/LF for Figure 5

Symbol	Min	Тур	Max	Unit
Α	0.57	0.61	0.65	mm
A <sub>1</sub>	0.18	0.20	0.22	mm
A <sub>2</sub>	0.39	0.41	0.43	mm
b	0.21	0.26	0.31	mm
D	0.71	0.76	0.81	mm
E	0.71	0.76	0.81	mm
е	-	0.4	-	mm

#### **Dual channel low capacitance ESD protection**

Table 6.	Dimensions of	IP4359CX4/LF-H500	) for Figure 5
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Symbol	Min	Тур	Max	Unit
Α	0.41	0.45	0.49	mm
A <sub>1</sub>	0.18	0.20	0.22	mm
$A_2$	0.23	0.25	0.27	mm
b	0.21	0.26	0.31	mm
D	0.71	0.76	0.81	mm
E	0.71	0.76	0.81	mm
е	-	0.4	-	mm

# 8. Design and assembly recommendations

## 8.1 PCB design guidelines

For optimum performance it is recommended to use a Non-Solder Mask Defined (NSMD), also known as a copper-defined design, incorporating laser-drilled micro-vias connecting the ground pads to a buried ground-plane layer. This results in the lowest possible ground inductance and provides the best high frequency and ESD performance. For this case, refer to Table 7 for the recommended PCB design parameters.

Table 7. Recommended PCB design parameters

Parameter	Value or specification
PCB pad diameter	250 μm
Micro-via diameter	100 μm (0.004 inch)
Solder mask aperture diameter	325 μm
Copper thickness	20 μm to 40 μm
Copper finish	AuNi or OSP
PCB material	FR4

## 8.2 PCB assembly guidelines for Pb-free soldering

Table 8. Assembly recommendations

Parameter	Value or specification
Solder screen aperture diameter	290 μm
Solder screen thickness	100 μm (0.004 inch)
Solder paste: Pb-free	SnAg (3 % to 4 %) Cu (0.5 % to 0.9 %)
Solder / flux ratio	50 / 50
Solder reflow profile	see Figure 6

## **Dual channel low capacitance ESD protection**

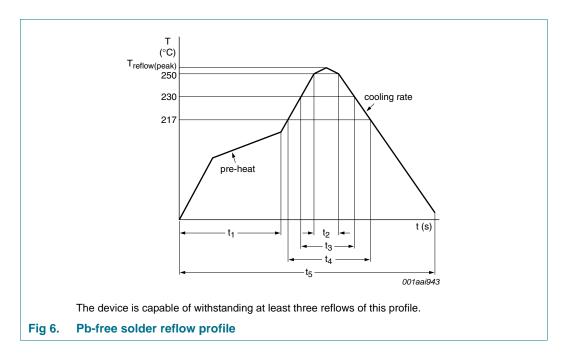


Table 9. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$T_{reflow(peak)}$	peak reflow temperature		230	-	260	°C
$t_1$	time 1	soak time	60	-	180	S
t <sub>2</sub>	time 2	time during T $\geq$ 250 °C	-	-	30	S
t <sub>3</sub>	time 3	time during T $\geq$ 230 °C	10	-	50	S
t <sub>4</sub>	time 4	time during T > 217 $^{\circ}$ C	30	-	150	S
t <sub>5</sub>	time 5		-	-	540	S
dT/dt	rate of change of temperature	cooling rate	-	-	-6	°C/s
		pre-heat	2.5	-	4.0	°C/s

## **Dual channel low capacitance ESD protection**

# 9. Abbreviations

#### Table 10. Abbreviations

Acronym	Description	
DUT	Device Under Test	
DVI	Digital Visual Interface	
ESD	ElectroStatic Discharge	
FR4	Flame Retard 4	
HDMI	High Definition Multimedia Interface	
IEC	International Electrotechnical Commission	
NSMD	Non-Solder Mask Defined	
NWA	NetWork Analyzer	
OSP	Organic Solderability Preservative	
PCB	Printed-Circuit Board	
RoHS	Restriction of Hazardous Substances	
USB	Universal Serial Bus	
WLCSP	Wafer-Level Chip-Scale Package	

# 10. Revision history

## Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
IP4359CX4 v.1	20100806	Product data sheet	-	-

#### **Dual channel low capacitance ESD protection**

# 11. Legal information

#### 11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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## **Dual channel low capacitance ESD protection**

# 13. Contents

1	Product profile
1.1	General description 1
1.2	Features and benefits
1.3	Applications
2	Pinning information 2
3	Ordering information
4	Limiting values 3
5	Characteristics 3
6	Application information 4
6.1	Insertion loss 4
6.2	Crosstalk 5
7	Package outline 6
8	Design and assembly recommendations 7
8.1	PCB design guidelines 7
8.2	PCB assembly guidelines for Pb-free
	soldering
9	Abbreviations 9
10	Revision history 9
11	Legal information 10
11.1	Data sheet status
11.2	Definitions
11.3	Disclaimers
11.4	Trademarks11
12	Contact information 11
13	Contents 12

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